


<b>Search Notes</b>  	<b>Application/Control No.</b>  10551264	<b>Applicant(s)/Patent Under Reexamination</b>  TANIWAKI ET AL.
	<b>Examiner</b>  MONZER R CHORBAJI	<b>Art Unit</b>  1797

SEARCHED			
Class	Subclass	Date	Examiner
422	1,21,22,186	07/17/2009	MRC
47	1.3,905,dig.10,1.42	07/17/2009	MRC
250	455.11	07/17/2009	MRC
111	118,127,200	07/17/2009	MRC

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (US-PGPUB, USPAT, EPO, JPO, USOCR, DERWENT, IBM_TDB)	07/17/2009	MRC
Conducted inventor name search	07/17/2009	MRC
Conducted assignee search	07/17/2009	MRC
422/1,21,22,186 (text search only - see search history printout)	07/17/2009	MRC
47/1.3,905,dig.10,1.42 (text search only - see search history printout)	07/17/2009	MRC
250/455.11(text search only - see search history printout)	07/17/2009	MRC
111/118,127,200 (text search only - see search history printout)	07/17/2009	MRC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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